

Notice of References Cited	Application/Control No. 10/002,356	Applicant(s)/Patent Under Reexamination SEAMAN ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,833,848	12-2004	Wolff et al.	715/719
	B	US-6,608,563	08-2003	Weston et al.	340/573.1
	C	US-6,362,850	03-2002	Alsing et al.	348/239
	D	US-2003/0085913	05-2003	Ahmad et al.	345/730
	E	US-2001/0048802	12-2001	Nakajima et al.	386/46
	F	US-2004/0268224	12-2004	Balkus et al.	715/500.1
	G	US-2004/0071441	04-2004	Foreman et al.	386/052
	H	US-6,628,303	09-2003	Foreman et al.	715/723
	I	US-6,400,378	06-2002	Snook, Stephen Tupper	715/716
	J	US-6,230,172	05-2001	Purnaveja et al.	715/512
	K	US-6,154,600	11-2000	Newman et al.	386/4
	L	US-5,760,767	06-1998	Shore et al.	715/723
	M	US-2001/0041049	11-2001	KANDA, TAKESHI	386/52

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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